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Fairchild Semiconductor 74F10PC

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FAIRCHILD

SEMICONDUCTOR

74F10 Triple 3-Input NAND Gate

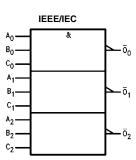
General Description

This device contains three independent gates, each of which performs the logic NAND function.

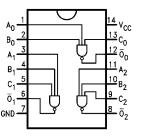
Ordering Code:

Order Number	Package Number	Package Description					
74F10SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow					
74F10SJ M14D 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide							
74F10PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide					
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.							

Logic Symbol



Connection Diagram



April 1988

Revised September 2000

Unit Loading/Fan Out

Pin N	Pin Names	Description	U.L.	Input I _{IH} /I _{IL}	
		Decomption	HIGH/LOW	Output I _{OH} /I _{OL}	
	A _n , B _n , C _n	Inputs	1.0/1.0	20 µA/-0.6 mA	
	\overline{O}_n	Outputs	50/33.3	–1 mA/20 mA	

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Absolute Maximum Ratings(Note 1)

	Storage Temperature	-65°C to +150°C
	Ambient Temperature under Bias	-55°C to +125°C
	Junction Temperature under Bias	-55°C to +150°C
Junction Temperature under Bia V _{CC} Pin Potential to Ground Pin Input Voltage (Note 2) Input Current (Note 2) Voltage Applied to Output		-0.5V to +7.0V
	Input Voltage (Note 2)	-0.5V to +7.0V
	Input Current (Note 2)	-30 mA to +5.0 mA
	Voltage Applied to Output	
	in HIGH State (with $V_{CC} = 0V$)	
	Standard Output	–0.5V to V_{CC}
	3-STATE Output	-0.5V to +5.5V
	Current Applied to Output	
	in LOW State (Max)	twice the rated I _{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature Supply Voltage 0°C to +70°C +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

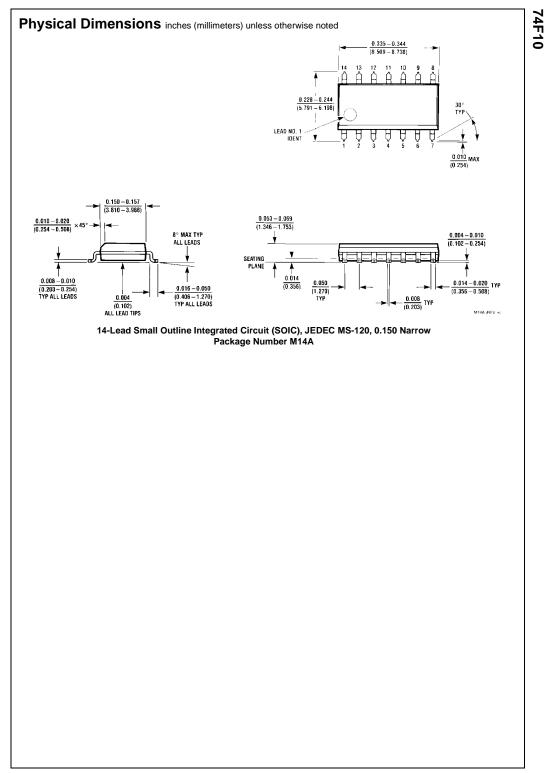
Symbol	Symbol Parameter		Min	Тур	Max	Units	v _{cc}	Conditions	
VIH	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage	9			-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	IGH 10% V _{CC}				V	Min	I _{OH} = -1 mA	
	Voltage	5% V _{CC}	2.7			v	IVIIII	$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW	10% V _{CC}			0.5	V	Min	L = 20 m A	
	Voltage				0.5			I _{OL} = 20 mA	
IIH	Input HIGH				5.0	μΑ	Max	V _{IN} = 2.7V	
	Current				5.0				
I _{BVI}	Input HIGH Current				7.0	μA	Max	V _{IN} = 7.0V	
	Breakdown Test				7.0	μΑ	IVIAX		
I _{CEX}	Output HIGH				50	μA	Max	V _{OUT} = V _{CC}	
	Leakage Current				50	μΑ	IVIAX		
V _{ID}	Input Leakage		4.75			V	0.0	I _{ID} = 1.9 μA	
	Test		4.75			v	0.0	All other pins grounded	
I _{OD}	Output Leakage				3.75	μA	0.0	V _{IOD} = 150 mV	
	Circuit Current				3.75	μΑ	0.0	All other pins grounded	
IIL	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V	
los	Output Short-Circuit Curre	nt	-60		-150	mA	Max	V _{OUT} = 0V	
I _{ССН}	Power Supply Current			1.4	2.1	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current			5.1	7.7	mA	Max	V _O = LOW	

AC Electrical Characteristics

Symbol	Parameter	$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_A = -55^{\circ}C$	C to +125°C	$T_A = 0^{\circ}C$ to $+70^{\circ}C$		
					V _{CC} = +5.0V C _L = 50 pF		V _{CC} = +5.0V C _L = 50 pF		Units
t _{PLH}	Propagation Delay	2.4	3.7	5.0	2.0	7.0	2.4	6.0	20
t _{PHL}	A_n, B_n, C_n to \overline{O}_n	1.5	3.2	4.3	1.5	6.5	1.5	5.3	ns

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